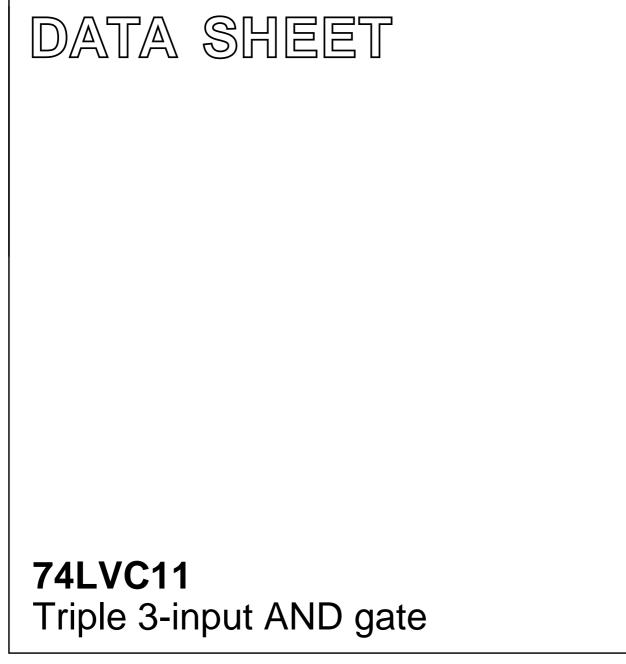
# INTEGRATED CIRCUITS



Product specification Supersedes data of 1998 Apr 28 2004 Jan 13



### 74LVC11

### FEATURES

- Wide supply voltage range from 1.2 to 3.6 V
- Inputs accept voltages up to 5.5 V
- CMOS low power consumption
- Direct interface with TTL levels
- · Output capability: standard
- I<sub>CC</sub> category: SSI
- In accordance with JEDEC standard no. 8-1A
- ESD protection: HBM EIA/JESD22-A114-A exceeds 2000 V MM EIA/JESD22-A115-A exceeds 200 V.

#### QUICK REFERENCE DATA

GND = 0 V;  $T_{amb} = 25 \text{ °C}$ ;  $t_r = t_f \le 2.5 \text{ ns.}$ 

### DESCRIPTION

The 74LVC11 is a high-performance, low power, low-voltage, Si-gate CMOS device and superior to most advanced CMOS compatible TTL families.

The 74LVC11 provides the 3-input AND function.

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t <sub>PHL</sub> /t <sub>PLH</sub>	propagation delay nA, nB, nC to nY	$C_L = 50 \text{ pF}; V_{CC} = 3.3 \text{ V}$	3.7	ns
CI	input capacitance		5.0	pF
C <sub>PD</sub>	power dissipation capacitance per gate	notes 1 and 2	26	pF

#### Notes

1.  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ).

 $P_{D} = C_{PD} \times V_{CC}^{2} \times f_{i} \times N + \Sigma (C_{L} \times V_{CC}^{2} \times f_{o}) \text{ where:}$ 

 $f_i$  = input frequency in MHz;

 $f_o = output frequency in MHz;$ 

 $C_L$  = output load capacitance in pF;

 $V_{CC}$  = supply voltage in Volts;

N = total switching outputs;

 $\Sigma(C_L \times V_{CC}{}^2 \times f_o)$  = sum of the outputs.

2. The condition is  $V_I = GND$  to  $V_{CC}$ .

### **ORDERING INFORMATION**

	TEMPERATURE RANGE	PACKAGE				
	TEMPERATURE RANGE	PINS	PACKAGE	MATERIAL	CODE	
74LVC11D	–40 to +85 °C	14	SO14	plastic	SOT108-1	
74LVC11DB	–40 to +85 °C	14	SSOP14	plastic	SOT337-1	
74LVC11PW	–40 to +85 °C	14	TSSOP14	plastic	SOT402-1	
74LVC11BQ	–40 to +85 °C	14	DHVQFN14	plastic	SOT762-1	

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FUNCTION TABLE

See note 1.

	OUTPUT		
nA	nB	nC	nY
L	L	L	L
L	L	Н	L
L	Н	L	L
L	Н	Н	L
Н	L	L	L
Н	L	Н	L
Н	Н	L	L
Н	Н	Н	Н

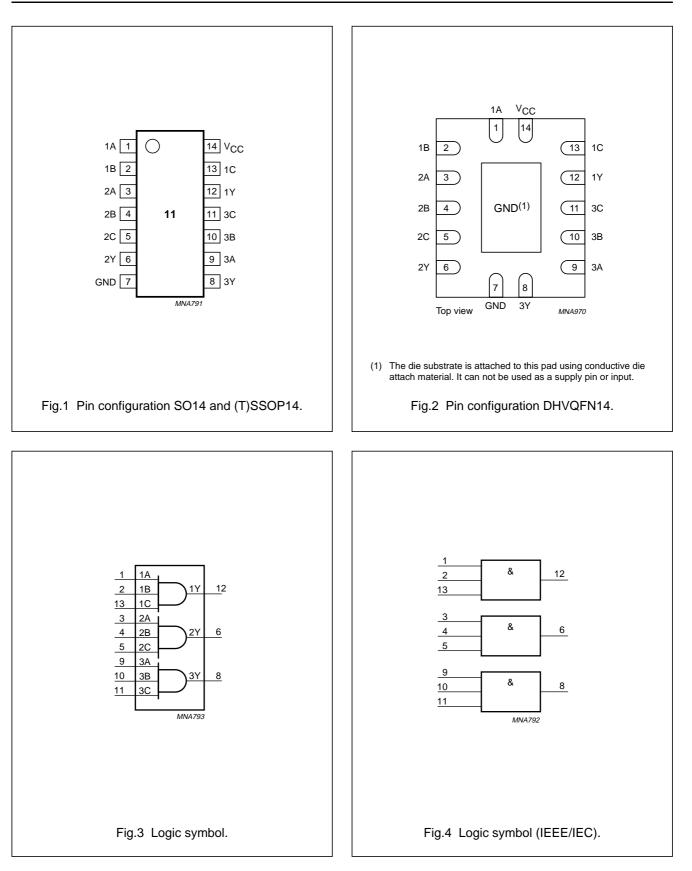
#### Note

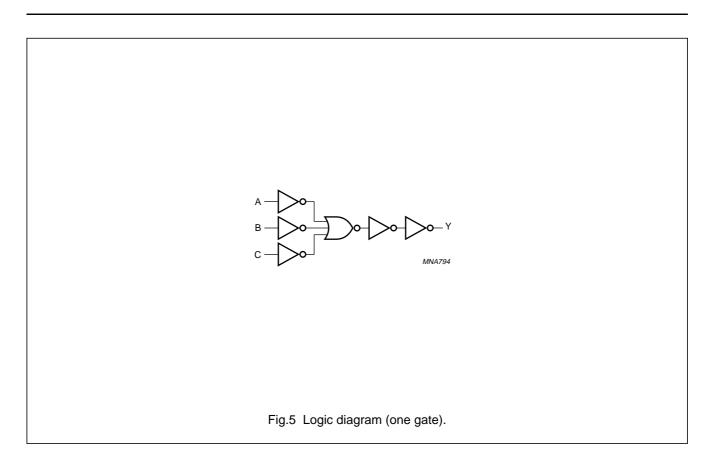
1. H = HIGH voltage level.

L = LOW voltage level.

### PINNING

PIN	SYMBOL	DESCRIPTION
1	1A	data input
2	1B	data input
3	2A	data input
4	2B	data input
5	2C	data input
6	2Y	data output
7	GND	ground (0 V)
8	3Y	data output
9	3A	data input
10	3B	data input
11	3C	data input
12	1Y	data output
13	1C	data input
14	V <sub>CC</sub>	positive supply voltage





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### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CC</sub>	supply voltage	for maximum speed performance	2.7	3.6	V
		for low-voltage applications	1.2	3.6	V
VI	input voltage		0	5.5	V
Vo	output voltage		0	V <sub>CC</sub>	V
T <sub>amb</sub>	operating ambient temperature		-40	+85	°C
t <sub>r</sub> , t <sub>f</sub>	input rise and fall times	V <sub>CC</sub> = 1.2 to 2.7 V	0	20	ns/V
		V <sub>CC</sub> = 2.7 to 3.6 V	0	10	ns/V

#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134); voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CC</sub>	supply voltage		-0.5	+6.5	V
I <sub>IK</sub>	input diode current	V <sub>1</sub> < 0	-	-50	mA
VI	input voltage	note 1	-0.5	+6.5	V
I <sub>OK</sub>	output diode current	$V_{\rm O} > V_{\rm CC}$ or $V_{\rm O} < 0$	-	±50	mA
Vo	output voltage	note 1	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>O</sub>	output source or sink current	$V_{O} = 0$ to $V_{CC}$	-	±50	mA
I <sub>GND</sub> , I <sub>CC</sub>	V <sub>CC</sub> or GND current		-	±100	mA
T <sub>stg</sub>	storage temperature range		-65	+150	°C
P <sub>tot</sub>	power dissipation	$T_{amb} = -40$ to +125 °C; note 2	-	500	mW

### Notes

- 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
- 2. For SO14 packages: above 70  $^\circ\text{C}$  the value of P\_D derates linearly with 8 mW/K.

For (T)SSOP14 packages: above 60 °C the value of  $P_D$  derates linearly with 5.5 mW/K. For DHVQFN14 packages: above 60 °C the value of  $P_D$  derates linearly with 4.5 mW/K.

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### DC CHARACTERISTICS

At recommended operating conditions voltages are referenced to GND (ground = 0 V).

SVMDO	DADAMETED	TEST CONDITIONS					
SYMBOL	PARAMETER	OTHER	V <sub>CC</sub> (V)	MIN.	<b>TYP.</b> <sup>(1)</sup>	MAX.	
T <sub>amb</sub> = -40	) °C to +85 °C		·	I		·	•
V <sub>IH</sub>	HIGH level input voltage		1.2	V <sub>CC</sub>	-	-	V
			2.7 to 3.6	2.0	-	_	V
VIL	LOW-level input voltage		1.2	_	-	GND	V
			2.7 to 3.6	_	-	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	$V_{I} = V_{IH} \text{ or } V_{IL}$					
		I <sub>O</sub> = -12 mA	2.7	V <sub>CC</sub> – 0.5	_	_	V
		I <sub>O</sub> = −100 μA	3.0	V <sub>CC</sub> – 0.2	V <sub>CC</sub>	_	V
		I <sub>O</sub> = -12 mA	3.0	V <sub>CC</sub> – 0.6	-	_	V
		I <sub>O</sub> = -24 mA	3.0	V <sub>CC</sub> – 1.0	-	_	V
V <sub>OL</sub>	LOW-level output voltage	$V_{I} = V_{IH} \text{ or } V_{IL}$					
		I <sub>O</sub> = 12 mA	2.7	_	-	0.40	V
		I <sub>O</sub> = 100 μA	3.0	_	GND	0.20	V
		I <sub>O</sub> = 24 mA	3.0	_	-	0.55	V
ILI	input leakage current	$V_I = 5.5 V \text{ or GND}$	3.6	_	±0.1	±5	μA
I <sub>CC</sub>	quiescent supply current	$V_{I} = V_{CC}$ or GND; $I_{O} = 0$	3.6	-	0.1	10	μA
$\Delta I_{CC}$	additional quiescent supply current per input pin	$V_{I} = V_{CC} - 0.6 \text{ V};$ $I_{O} = 0$	2.7 to 3.6	-	5	500	μΑ

### Note

1. All typical values are measured at V\_{CC} = 3.3 V and T\_{amb} = 25 °C.

### AC CHARACTERISTICS

GND = 0 V;  $t_r$  =  $t_f$   $\leq$  2.5 ns;  $C_L$  = 50 pF;  $R_L$  = 500  $\Omega$ .

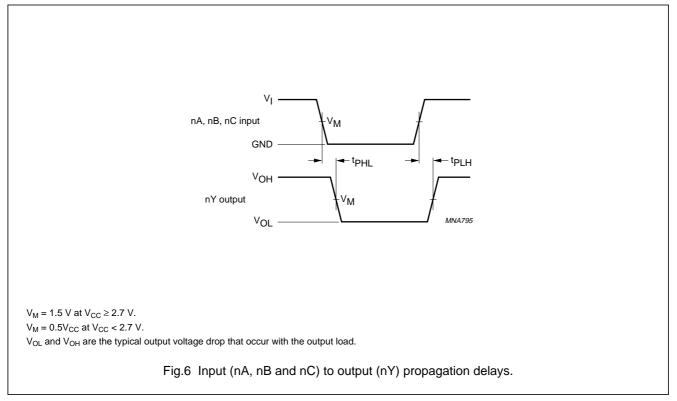
SYMBOL	PARAMETER	TEST CONDI	TEST CONDITIONS		<b>TYP.</b> <sup>(1)</sup>	MAX.	UNIT
STIVIDOL	FARAMETER	WAVEFORMS	V <sub>CC</sub> (V)	MIN.			UNIT
T <sub>amb</sub> = -40	T <sub>amb</sub> = -40 to +85 °C						
t <sub>PHL</sub> /t <sub>PLH</sub>	propagation delay	see Figs 6 and 7	2.7	_	_	7.0	ns
			3.0 to 3.6	_	3.7	6.2	ns

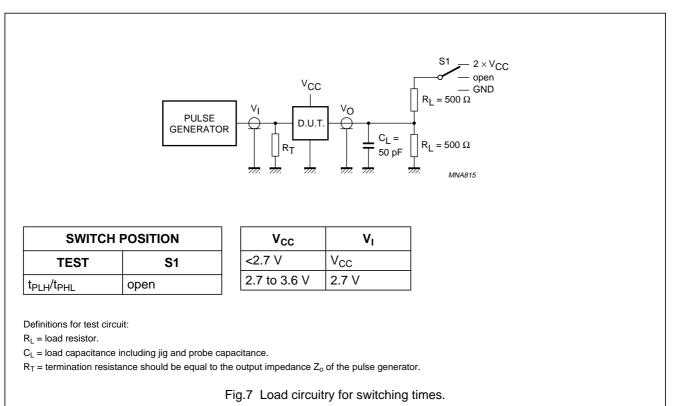
#### Note

1. Typical value is measured at V\_{CC} = 3.3 V and T\_{amb} = 25 °C.

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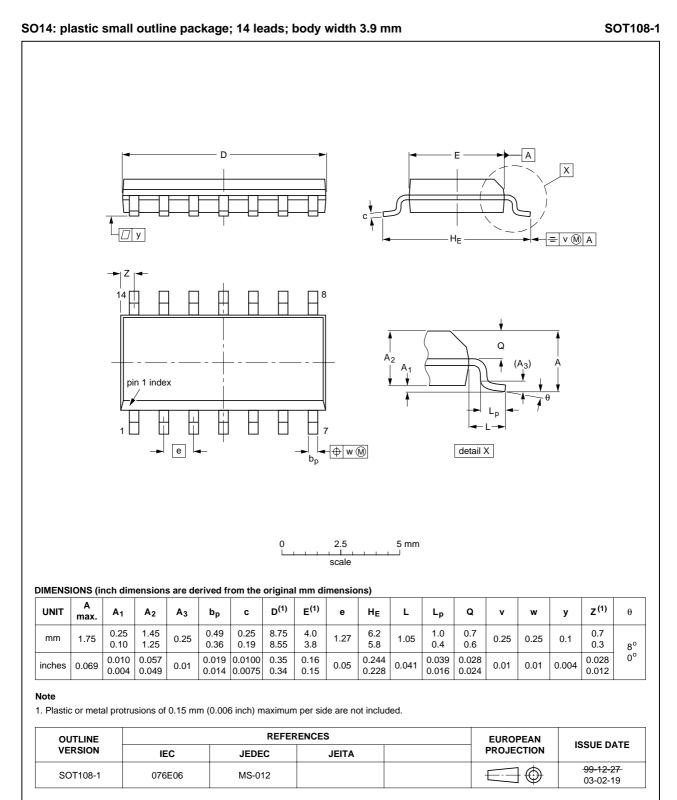
### AC WAVEFORMS

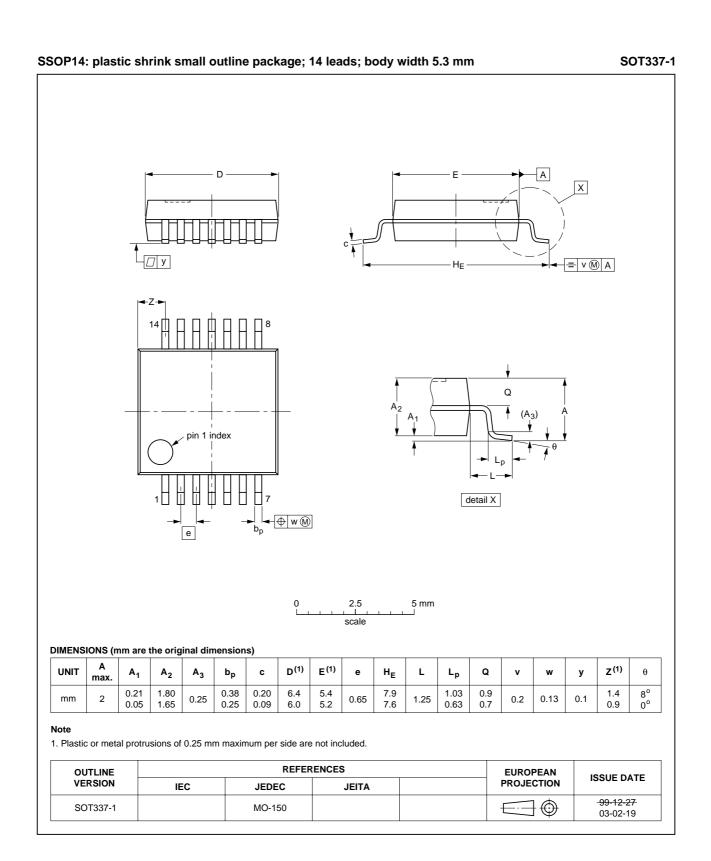


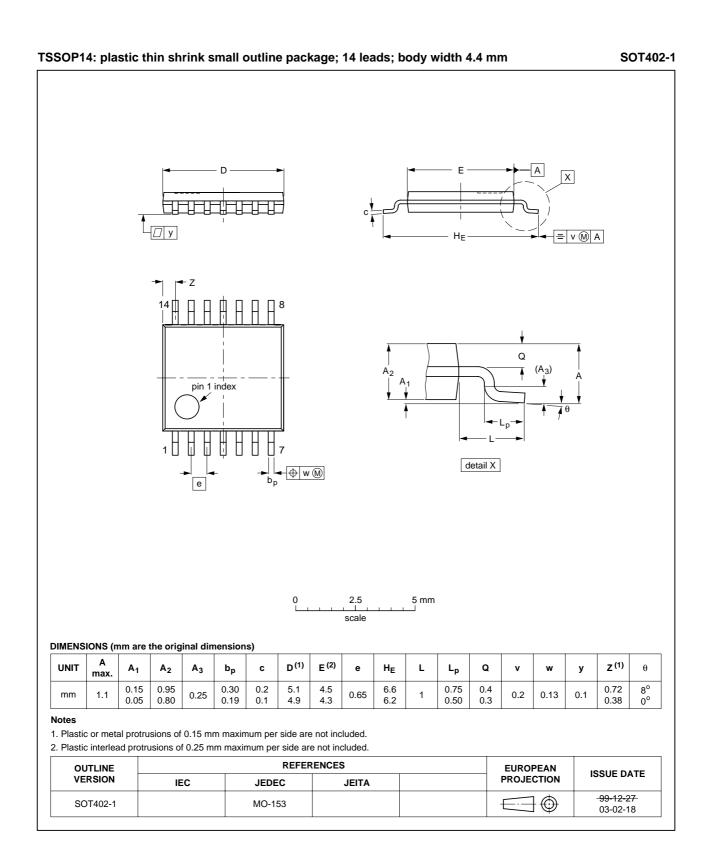


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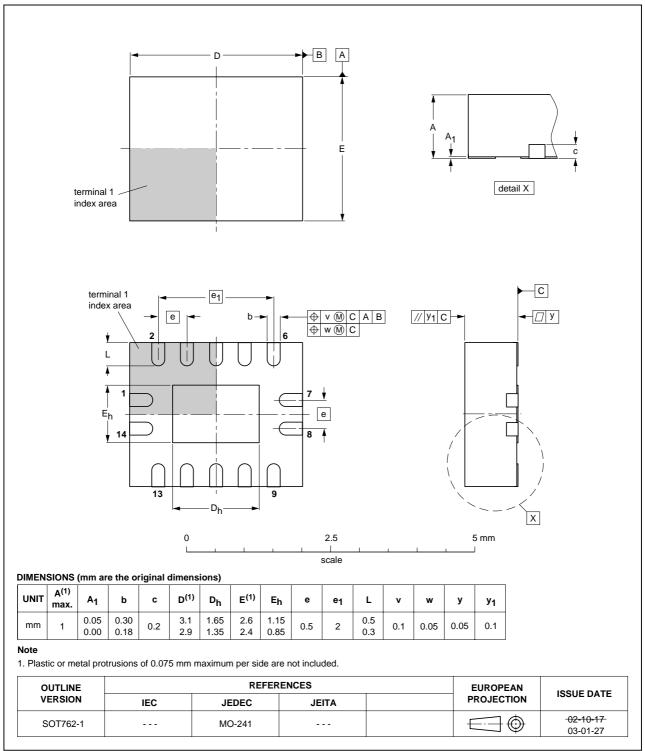
### PACKAGE OUTLINES







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#### DHVQFN14: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body 2.5 x 3 x 0.85 mm SOT762-1

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#### DATA SHEET STATUS

LEVEL	DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)(3)</sup>	DEFINITION
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